

**Notice of References Cited**

Application/Control No.

10/629,033

Applicant(s)/Patent Under  
Reexamination  
MAYO ET AL.

Examiner

ERIC C. WAI

Art Unit

2195

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0055969	03-2003	Begun et al.	709/226
*	B	US-7,523,454	04-2009	Romero et al.	718/105
*	C	US-6,801,926	10-2004	Shisler et al.	709/201
*	D	US-6,085,216	07-2000	Huberman et al.	718/104
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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